

**Search Notes**

Application/Control No.

10/668,010

Examiner

Hal I. Kaplan

Applicant(s)/Patent under  
Reexamination

SINHA ET AL.

Art Unit

2836

**SEARCHED**

Class	Subclass	Date	Examiner
307	651	2/14/2006	HK
374	172	2/14/2006	HK
374	176	2/14/2006	HK
702	99	2/15/2006	HK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
324/71.1,76.44,705,713,721 (consulted Anjan Deb)	2/14/2006	HK
327/78 (consulted Terry Cunningham)	2/14/2006	HK
327/512,513; 374/1,170,172,176,178 (consulted Gail Verbitsky)	2/14/2006	HK
361/103,106 (consulted Stephen W. Jackson)	2/14/2006	HK
361/687 (consulted Lisa Lea- Edmonds)	2/14/2006	HK
702/99,130 (consulted Bryan Bui)	2/15/2006	HK
EAST (US-PGPUB,USPAT,USOCR, EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/14/2006	HK

**Search Notes (continued)**

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EAST (US-PGPUB,USPAT,USOCR, EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/16/2006	HK
324/71.1,76.44,705,713,721; 327/78,512,513; 361/103,106; 374/1,170 (cursory)	2/14/2006	HK
361/687; 702/130 (cursory)	2/15/2006	HK